## **IN THE CLAIMS:**

Please amend the claims as follows:

- 1. (Currently Amended) An ultra-thin copper foil with a carrier comprised of a carrier foil, a peeling layer, and an ultra-thin copper foil layer, wherein said ultra-thin copper foil layer and said peeling layer are provided between them with a strike plating layer and wherein said ultra-thin copper foil layer and said strike plating layer are one of a phosphorus-containing copper layer and a phosphorus-containing copper alloy layer and wherein said peeling layer and said strike plating layer are composed of materials that are distinct and different from each other.
- 2. (Currently Amended) An ultra-thin copper foil with a carrier comprised of a carrier foil, a peeling layer, and an ultra-thin copper foil layer, wherein said ultra-thin copper foil layer and said peeling layer are provided between them with a strike plating layer comprised of one of a phosphorus-containing copper layer and a phosphorus-containing copper alloy layer, said strike plating layer is provided thereon on it with a copper plating ultra-thin layer, and said ultra-thin layer is provided thereon on it with said ultra-thin copper foil layer comprised of one of copper and a copper alloy and wherein said peeling layer and said strike plating layer are composed of materials that are distinct and different from each other.
- 3. (**Currently Amended**) An ultra-thin copper foil with a carrier comprised of a carrier foil, a peeling layer, and an ultra-thin copper foil <u>layer</u>, wherein said ultra-thin copper foil <u>layer</u> and said peeling layer are provided between them with a strike plating layer comprised of one of a phosphorus-containing copper layer and a phosphorus-containing copper alloy layer, said strike plating layer is provided <u>thereon</u> on it with a

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copper plating ultra-thin layer, and said ultra-thin layer is provided thereon on it with said ultra-thin copper foil layer comprised of one of a phosphorus-containing copper layer and a phosphorus-containing copper alloy layer and wherein said peeling layer and said strike plating layer are composed of materials that are distinct and different from each other.

- 4. (Currently Amended) An ultra-thin copper foil with a carrier comprised of a carrier foil, a peeling layer, and an ultra-thin copper foil layer, wherein said ultra-thin copper foil layer and said peeling layer are provided between them with a strike plating layer comprised of one of a phosphorus-containing copper layer and a phosphorus-containing copper alloy layer, said strike plating layer is provided on-it thereon with an ultra-thin layer comprised of one of a phosphorus-containing copper layer and phosphorus-containing copper alloy layer, and the ultra-thin layer is provided on-it thereon with said ultra-thin copper foil layer comprised of one of copper and a copper alloy and wherein said peeling layer and said strike plating layer are composed of materials that are distinct and different from each other.
- 5. (Currently Amended) An ultra-thin copper foil with a carrier comprised of a carrier foil, a peeling layer, and an ultra-thin copper foil layer, wherein said ultra-thin copper foil layer and said peeling layer are provided between them with a strike plating layer comprised of one of a phosphorus-containing copper layer and a phosphorus-containing copper alloy layer, said strike plating layer is provided thereon on it with an ultra-thin layer comprised of one of a phosphorus-containing copper layer and phosphorus-containing copper alloy layer, and the ultra-thin layer is provided thereon on it with said ultra-thin copper foil layer comprised of one of a phosphorus-containing copper layer

containing copper and a phosphorus-containing copper alloy and wherein said peeling layer and said strike plating layer are composed of materials that are distinct and different from each other.

- 6. (Currently Amended) An ultra-thin copper foil with a carrier comprised of a carrier foil, a peeling layer provided on the carrier foil, and an ultra-thin copper foil layer provided on the peeling layer, wherein a surface roughness Rz of a surface of the carrier foil facing the ultra-thin copper layer on the ultra-thin copper foil side is in a range of 0.1 µm to 5 µm, a surface roughness Rz of a surface of the ultra-thin copper layer facing the carrier foil side of the ultra-thin copper foil provided on the peeling layer provided on said carrier foil surface is in a range of 0.1 µm to 5 µm, and wherein there is disposed between said peeling layer and said ultra-thin copper layer a copper or copper alloy layer covering at least 90% of a surface of the peeling layer facing the ultra-thin copper layer at a position approximately 0.1 µm to 0.2 µm away from an average height of projections extending from a surface relief of a surface of the peeling layer facing the ultra-thin copper layer one of a copper and copper alloy layer covering at least 90% of the area of the surface of the peeling layer is formed at a position of the surface roughness Rz of the ultra-thin copper foil plus 0.1 µm to 0.2 µm at the ultra-thin copper foil side from the projections of the surface relief on the carrier foil side of the ultra-thin copper foil, and a peel strength after hot bonding of at least 300°C is 0.01 KN/m to 0.05 KN/m.
- 7. (**Currently Amended**) An ultra-thin copper foil with a carrier comprised of a carrier foil, a peeling layer <u>provided on the carrier foil</u>, and an ultra-thin copper foil <u>layer</u> provided on the peeling <u>layer</u>, wherein a surface roughness Rz of a surface of the

carrier foil facing the ultra-thin copper layer on the ultra-thin copper foil side is in a range of 0.1 µm to 5 µm, a surface roughness Rz of a surface of the ultra-thin copper layer facing the carrier foil side of the ultra-thin copper foil provided on the peeling layer provided on said carrier foil surface is in a range of 0.1 µm to 5 µm, and wherein there is disposed between said peeling layer and said ultra-thin copper layer a copper or copper alloy layer having a conductivity of at least 90% formed on a surface of the peeling layer facing the ultra-thin copper layer at a position approximately 0.1 µm to 0.2 µm away from an average height of projections extending from a surface relief of a surface of the peeling layer facing the ultra-thin copper layer one of a copper and copper alloy layer having a conductivity of at least 90% is formed at a position of the surface roughness Rz of the ultra-thin copper foil plus 0.1 µm to 0.2 µm at the ultra-thin copper foil side from the projections of the surface relief on the carrier foil side of the ultra-thin copper foil, and a peel strength after hot bonding of at least 300°C is 0.01 KN/m to 0.05 KN/m.

- 8. (**Currently Amended**) An ultra-thin copper foil with a carrier as set forth in any one of claims 1 to 5, wherein the <u>a</u> surface roughness Rz of the <u>a surface of the</u> carrier foil surface at <u>facing</u> the ultra-thin copper foil <u>layer side</u> is <u>in a range of</u> 0.1 μm to 5 μm and the <u>wherein a</u> peel strength after hot bonding of at least 300°C is 0.01 KN/m to 0.05 KN/m.
- 9. (**Currently Amended**) An ultra-thin copper foil with a carrier as set forth in any one of claims 1 to 5, wherein a surface roughness Rz of a surface of the carrier foil facing the ultra-thin copper layer on the ultra-thin copper foil side is in a range of 0.1 µm to 5 µm, a surface roughness Rz of a surface of the ultra-thin copper layer facing the carrier foil side of the ultra-thin copper foil provided on the peeling layer provided on

between said peeling layer and said ultra-thin copper layer a copper or copper alloy layer covering at least 90% of a surface of the peeling layer facing the ultra-thin copper layer at a position approximately 0.1 μm to 0.2 μm away from an average height of projections extending from a surface relief of a surface of the peeling layer facing the ultra-thin copper layer one of a copper and copper alloy layer covering at least 90% of the area of the peeling layer surface is formed at a position of the surface roughness Rz of the ultra-thin copper foil plus 0.1 μm to 0.2 μm at the ultra-thin copper foil side from the projections of the surface relief on the carrier foil side of the ultra-thin copper foil, and a peel strength after hot bonding of at least 300°C is 0.01 KN/m to 0.05 KN/m.

10.(Currently Amended) An ultra-thin copper foil with a carrier as set forth in any one of claims 1 to 5, wherein a surface roughness Rz of a surface of the carrier foil facing the ultra-thin copper layer on the ultra-thin copper foil side is in a range of 0.1 μm to 5 μm, a surface roughness Rz of a surface of the ultra-thin copper layer facing the carrier foil side of the ultra-thin copper foil provided on the peeling layer provided on said carrier foil surface is in a range of 0.1 μm to 5 μm, and wherein there is disposed between said peeling layer and said ultra-thin copper layer a copper or copper alloy layer having a conductivity of at least 90% formed on the surface of the peeling layer facing the ultra-thin copper layer at a position approximately 0.1 μm to 0.2 μm away from an average height of projections extending from a surface relief of a surface of the peeling layer facing the ultra-thin copper layer one of a copper and copper alloy layer having a conductivity of at least 90% is formed at a position of the surface roughness Rz of the ultra-thin copper foil plus 0.1 μm to 0.2 μm at the ultra-thin copper roughness Rz of the ultra-thin copper foil plus 0.1 μm to 0.2 μm at the ultra-thin copper

foil side from the projections of the surface relief on the carrier foil side of the ultra thin copper foil, and a peel strength after hot bonding of at least 300°C is 0.01 KN/m to 0.05 KN/m.

- 11. (**Original**)An ultra-thin copper foil with a carrier as set forth in any one of claims 1 to 7, wherein said peeling layer is one of a chromium metal and chromium alloy.
- 12. (**Original**)An ultra-thin copper foil with a carrier as set forth in any one of claims 1 to 7, wherein said peeling layer is one of an oxide hydrate of a chromium metal and chromium alloy.
- 13. (**Original**)An ultra-thin copper foil with a carrier as set forth in any one of claims 1 to 7, wherein said peeling layer is formed by one of a chromium metal, chromium alloy, and oxide hydrate of one of a chromium metal and chromium alloy.
- 14. (**Original**)An ultra-thin copper foil with a carrier as set forth in claim 11, wherein the amount of deposited metal of one of a chromium metal and chromium alloy of the peeling layer is not more than 4.5 mg/dm<sup>2</sup>.
- 15. (**Original**)An ultra-thin copper foil with a carrier as set forth in claim 12, wherein the amount of deposited metal of one of a chromium metal and chromium alloy in the peeling layer comprised of an oxide hydrate is not more than 0.015 mg/dm<sup>2</sup>.
- 16. (**Original**)An ultra-thin copper foil with a carrier as set forth in claim 13, wherein the amount of deposited metal of one of a chromium metal and chromium alloy of the peeling layer is not more than 4.5 mg/dm<sup>2</sup>.

17.(**Original**)An ultra-thin copper foil with a carrier as set forth in any one of claims 1 and 5 to 7, wherein said peeling layer is one of nickel, iron, an alloy of the same, and an oxide hydrate containing the same.

- 18. (Cancelled)
- 19. (Cancelled)
- 20.(Cancelled)
- 21.(Cancelled)
- 22. (Cancelled)
- 23. (Cancelled)
- 24. (Cancelled)
- 25. (**Original**)A printed circuit board wherein an ultra-thin copper foil with a carrier as set forth in any one of claims 1 to 7 is used to form high density ultrafine interconnects.
  - 26.(Cancelled)
- 27.(Original)A printed circuit board wherein an ultra-thin copper foil with a carrier as set forth in claim 8 is used to form high density ultrafine interconnects.
- 28.(**Original**)A printed circuit board wherein an ultra-thin copper foil with a carrier as set forth in claim 9 is used to form high density ultrafine interconnects.
- 29.(**Original**)A printed circuit board wherein an ultra-thin copper foil with a carrier as set forth in claim 10 is used to form high density ultrafine interconnects.